

<b>Notice of References Cited</b>	Application/Control No. 10/562,581	Applicant(s)/Patent Under Reexamination OKAZAKI ET AL.	
	Examiner Derek J. Rosenau	Art Unit 2834	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,778,029	08-2004	Mizusawa, Syuichi	331/68
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#### NON-PATENT DOCUMENTS

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